

## 於。GDAŃSK UNIVERSITY 奶 OF TECHNOLOGY

## Subject card

Subject name and code	Optical Measurement Techniques, PG_00048097								
Field of study	Electronics and Telecommunications								
Date of commencement of studies	October 2024		Academic year of realisation of subject			2027/2028			
Education level	first-cycle studies		Subject group			Optional subject group Subject group related to scientific research in the field of study			
Mode of study	Full-time studies		Mode of delivery		at the university				
Year of study	4		Language of instruction		Polish				
Semester of study	7		ECTS credits		3.0				
Learning profile	general academic profile		Assessmer	ssessment form		exam			
Conducting unit	Department of Metrol	ogy and Optoe	lectronics -> Fa	aculty of Electr	onics, T	elecom	munications	and Informatics	
Name and surname	Subject supervisor		dr inż. Maciej Wróbel						
of lecturer (lecturers)	Teachers		dr inż. Maciej Wróbel						
Lesson types and methods of instruction	Lesson type	Lecture	Tutorial	Laboratory	Projec	:t	Seminar	SUM	
	Number of study hours	15.0	0.0	15.0	0.0		0.0	30	
	E-learning hours included: 0.0								
Learning activity and number of study hours	Learning activity	Participation i classes incluc plan			Self-study SL		SUM		
	Number of study hours	30		3.0		42.0		75	
Subject objectives	Provision of knowledge and abilities in the field of key optical measurement methods used in the industry and science.								
Learning outcomes	Course outcome		Subject outcome			Method of verification			
	[K6_W31] Knows the definitions of measurement error and uncertainty, measurement methods, including digital methods of time, frequency and phase measurements, transducer properties and knows digital signal processing systems.		Student is able to propose appropriate components and structures of spectral, interferometric and other optoelectronic measurement systems. Determines the sources of noise and interference in optoelectronic measurements			[SW1] Assessment of factual knowledge			
	[K6_U06] can analyse the operation of components, circuits and systems related to the field of study, measure their parameters and examine technical specifications		Analyzes the operation of spectrometers, interferometers and other optoelectronic measurement systems. Knows their measurement applications and the physical basis of their operation.			[SU1] Assessment of task fulfilment			

Subject contents	<b>1. Basic properties of light, interactions of light with matter.</b> Electromagnetic wave, wavelength, optical spectrum ranges Intensity, photometric and radiometric units, Polarization, Jones vector, Stokes vector, Poincare sphere Refraction and reflection of light, Diffraction, Near and far field, Diffraction limit, Diffraction orders Absorption, Absorbance, Lambert-Beer law.							
	<b>2. Light scattering and measurements of scattering parameters.</b> Light scattering, physical basics, Mie scattering description parameters Measurements of scattering and absorption parameters Integration spheres, construction, applications, Method of measuring radiometric parameters using spheres, Method of measuring scattering parameters using the IAD method, application in biomedicine.							
	<b>3. Synchronous detection in optical measurement methods.</b> The problem of noise in optical measurements Synchronous (phase-sensitive) detection theory Lock-in amplifier circuit Measuring applications							
	<b>4. Microscopy.</b> Basics of microscopy, image formation, resolution, PSF, contrastContrast improvement methods, bright field, dark field, Polarizing microscopy, phase contrast, confocal microscopy							
	<b>5. Spectrometry, Fluorescence.</b> Basics of spectral measurement methods, Jabłoński diagram, fluorescence, phosphorescence, absorption spectroscopy, fluorescence microscopy, emission and excitation spectra, spectrofluorimeter, confocal laser fluorescence microscopy, fluorescence lifetime, applications of measurement methods.							
	<b>6. Raman spectroscopy and IR spectroscopy.</b> Raman spectroscopy, configuration of measurement systems, basics of operation. IR spectroscopy, configuration of measurement systems, basics of operation. Raman microspectroscopy, optical probes, applications of measurement methods, analysis of measurement data.							
	<b>7. Interferometry.</b> Amplitude and wavefront division interferometers, interferometer designs, Advanced interferometric methods: FTIR, FT-Raman, Low-coherence interference, Optical coherence tomography (OCT) - in the time domain (TD-OCT) and spectrum (SD-OCT).							
Prerequisites and co-requisites	No requirements							
Assessment methods and criteria	Subject passing criteria	Passing threshold	Percentage of the final grade					
	Laboratory	50.0%	60.0%					
	Exam	50.0%	40.0%					
Recommended reading	Basic literature	<ol> <li>P.K. Rastogi, Optical Measurement Techniques and Applications, Artech Book House, 1998</li> <li>F Ratajczyk, Dwójłomność i polaryzacja optyczna, Oficyna Wydawnicza Politechniki Wrocławskiej, Wrocław 2000</li> <li>M. Pluta, Mikrointerferometria w świetle spolaryzowanym, WNT Warszawa 1991</li> <li>M. Born, E. Wolf, Principles of Optics, np. 6th Edition, Pergamon Press, Oxford 1993</li> </ol>						
	Supplementary literature	No requirements						
	eResources addresses	Adresy na platformie eNauczanie:						

11	polarized light based on the Poincaré sphere.
12	Describe the principle of operation of the synchronous detection method, the purpose of its use, the method of operation and the circuit diagram, formulas.
13	Introduce different methods for obtaining better contrast in microscopy. Describe the structure of a phase contrast microscope.
14	Describe the principle of operation of a confocal microscope. Scheme, idea and applications, also as a system in combination with other measurement methods.
15	Describe, based on Jabłoński diagrams, the phenomena of absorption, fluorescence, phosphorescence and scattering of elastic light.
16	Describe the principle of operation, physical basis, measurement systems, and basic laws describing the UV-VIS absorption spectroscopy method.
Work placement	ot applicable